

# 2010 DoD BIOMETRICS COLLABORA TION FORUM

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[www.biometrics.dod.mil](http://www.biometrics.dod.mil)

*Quality Management Algorithms*





# Quality Measurement Algorithms

- Leader:
  - Mr. Tom D’Agostino
  - Dr. Bob Yen
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- Overview:
  - DoD Biometric Sample Image Quality Requirements
  - BTF Biometric Sample Image Quality Algorithms and Toolsets
    - Key Benefits
    - Implementation
  - Future Development





## Session Objectives

- Challenges:
  - Providing the current status of developing vendor-neutral and DoD-owned biometric sample image quality measurement algorithms and toolsets.
  - Identifying the additional quality requirements to improve the capabilities of all quality measurement toolsets.
- Desired Outputs:
  - Commitments from DoD and USG agencies to field the quality tools and begin standardizing the quality of biometric samples.





## Findings and Insights

- Summarize key discussion points from the session.



## Next Steps and Timeline

- Highlight any progress (or breakthroughs) made during session.
- Outline the “way ahead” with a timeline for completion.